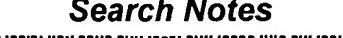


Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/675,736	SHEN ET AL.	
	Examiner	Art Unit	
	A. J. HEINZ	2627	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
see			
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History			